

Search Notes

Application/Control No.

10/625,208

Examiner

Alex Liew

Applicant(s)/Patent under
Reexamination

FARMER ET AL.

Art Unit

2624

SEARCHED

| Class | Subclass | Date | Examiner |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
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| 382/224 (limited to text search) | 11/6/2006 | AL |
| Overall East Text search | 11/6/2006 | AL |
| IEEE Database (limited to text search) | 11/17/2006 | AL |
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